

<b>Notice of References Cited</b>	Application/Control No. 10/034,072		Applicant(s)/Patent Under Reexamination SLUTSKY ET AL.	
	Examiner Ahshik Kim		Art Unit 2876	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,761,316	07-2004	Bridgelall et al.	235/462.46
*	B	US-2003/0127519	07-2003	Ehrhart et al.	235/469
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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